

AMTC2 The 2nd International Symposium on Advanced Microscopy and Theoretical Calculations



■ Invited Speakers

Interfaces and Grain Boundaries

J. W. Cahn (NIST/Univ. Washington)
S. J. Pennycook (ORNL/Vanderbilt Univ.)
F. Ernst (Case Western Reserve Univ.)
M. Rühle (MPI für Metallforschung)
N. D. Browning (LLNL/UCDavis)
C. B. Carter (Univ. Connecticut)
Y. Ikuhara (Univ. Tokyo / JFCC)

Electron Holography and Lorentz Microscopy

A. Tonomura (Hitachi Ltd.)
H. Lichte (TU Dresden)
D. Shindo (Tohoku Univ.)
J. Chapman (Univ. Glasgow)
Y. Zhu (BNL/Stony Brook Univ.)
T. Hirayama (JFCC)

Environmental TEM

R. Dunin-Borkowski (Technical Univ. Denmark)
P. L. Gai (Univ. York)
N. Tanaka (Nagoya Univ.)

Modeling and Simulations

J. Hafner (Univ. Vienna)
S. H. Wei (NREL)
D. Vanderbilt (Rutgers Univ.)
M. Finnis (Imperial College London)
W. Y. Ching (Univ. Missouri-Kansas City)
A. Shluger (University College London / Tohoku Univ.)
K. Matsunaga (Kyoto Univ./JFCC)
I. Tanaka (Kyoto Univ. / JFCC)

AMTC2 Special Topic: Frontiers of Materials Science

S. Iijima (Meijo Univ.)
K. Kitazawa (JST)
H. Hosono (Tokyo Tech)
T. Norby (Univ. Oslo)
S. J. L. Kang (KAIST)
X. Pan (Univ. Michigan)

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